Docket No.: 4590-477   **PATENT**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of   :
                                                  :
Olivier RUCH   :   Confirmation No.
                                                  :
U.S. Patent Application No. *not yet assigned*   :
                                                  :
Filed: *herewith*   :

For: METHOD FOR MEASURING THE PROXIMITY OF TWO CONTOURS AND SYSTEM FOR AUTOMATIC IDENTIFICATION OF TARGETS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above-identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37 CFR 1.56. A copy of the foreign search report is attached for the Examiner's information. Acknowledgement and consideration of these documents are respectfully requested.

Respectfully submitted,

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Date: January 17, 2006

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.R./

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)	ATTY. DOCKET NO. 4590-477	U.S. APPLICATION NO. Not yet assigned
	APPLICANT Olivier RUCH	
	FILING DATE herewith	GROUP

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation Yes	No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

	Dubuisson M-P et al: "A modified Hausdorff distance for object matching" Pattern Recognition, 1994. vol. 1-Conference A: Computer Vision & Image Processing., Proceedings of the 12th IAPR International Conference in Jerusalem, Israe l 9-13 Oct. 1994, Los Alamitos, CA, USA, IEEE, Comput. Soc, October 9, 1994, pages 566-568
	Toet A et al: "Genetic contour matching" Pattern Recognition Letter, North-Holland Publ. Amsterdam NL August 1, 1995 pages 849-856
	Huttenlocher D P et al : "Comparing images using the Hausdorff distance under translation" Proceeding of the Computer Society Conference on Computer Vision and Pattern Recognition Champaign, IL, June 15-18, 1992 New York, IEEE, US June 15, 1992 pages 654-656
	Gupta L et al : "Robust automatic target recognition using a localized boundary representation" Pattern Recognition, Pergamon Press Inc., Elmsford, NY US October 1, 1995 pages 1587-1598

EXAMINER /Manuchehr Rahmjoo/	DATE CONSIDERED 03/24/2009

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.R./